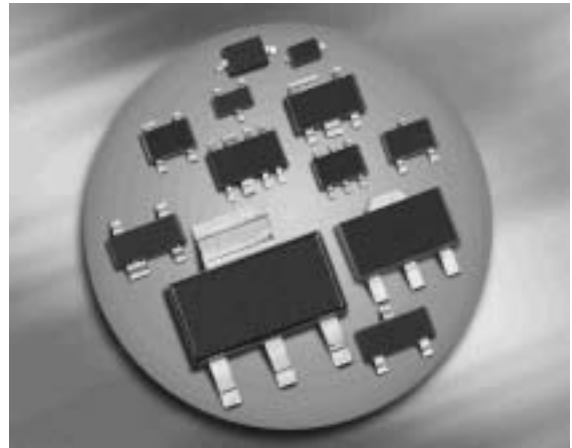


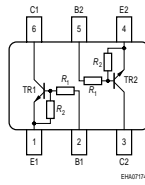
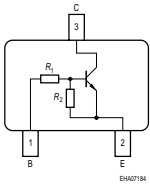
NPN Silicon Digital Transistor

- Switching in circuit, inverter, interface circuit, drive circuit
- Built in bias resistor ($R_1 = 10\text{ k}\Omega$, $R_2 = 10\text{ k}\Omega$)
- For 6-PIN packages: two (galvanic) internal isolated transistors with good matching in one package



**BCR133/F/L3
BCR133T/W**

**BCR133S/U
SEMH11**



Type	Marking	Pin Configuration						Package
BCR133	WCs	1=B	2=E	3=C	-	-	-	SOT23
BCR133F	WCs	1=B	2=E	3=C	-	-	-	TSFP-3
BCR133L3	WC	1=B	2=E	3=C	-	-	-	TSLP-3-4
BCR133S	WCs	1=E1	2=B1	3=C2	4=E2	5=B2	6=C1	SOT363
BCR133T	WCs	1=B	2=E	3=C	-	-	-	SC75
BCR133U	WCs	1=E1	2=B1	3=C2	4=E2	5=B2	6=C1	SC74
BCR133W	WC	1=B	2=E	3=C	-	-	-	SOT323
SEMH11	WC	1=E1	2=B1	3=C2	4=E2	5=B2	6=C1	SOT666

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CEO}	50	V
Collector-base voltage	V_{CBO}	50	
Emitter-base voltage	V_{EBO}	10	
Input on voltage	$V_{i(on)}$	20	
Collector current	I_C	100	mA
Total power dissipation- BCR133, $T_S \leq 102^\circ\text{C}$ BCR133F, $T_S \leq 128^\circ\text{C}$ BCR133L3, $T_S \leq 135^\circ\text{C}$ BCR133S, $T_S \leq 115^\circ\text{C}$ BCR133T, $T_S \leq 109^\circ\text{C}$ BCR133U, $T_S \leq 118^\circ\text{C}$ BCR133W, $T_S \leq 124^\circ\text{C}$ SEMH11, $T_S \leq 75^\circ\text{C}$	P_{tot}	200 250 250 250 250 250 250 250	mW
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-65 ... 150	

Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R_{thJS}		K/W
BCR133		≤ 240	
BCR133F		≤ 90	
BCR133L3		≤ 60	
BCR133S		≤ 140	
BCR133T		≤ 165	
BCR133U		≤ 133	
BCR133W		≤ 105	
SEMH11		≤ 300	

¹⁾For calculation of R_{thJA} please refer to Application Note Thermal Resistance

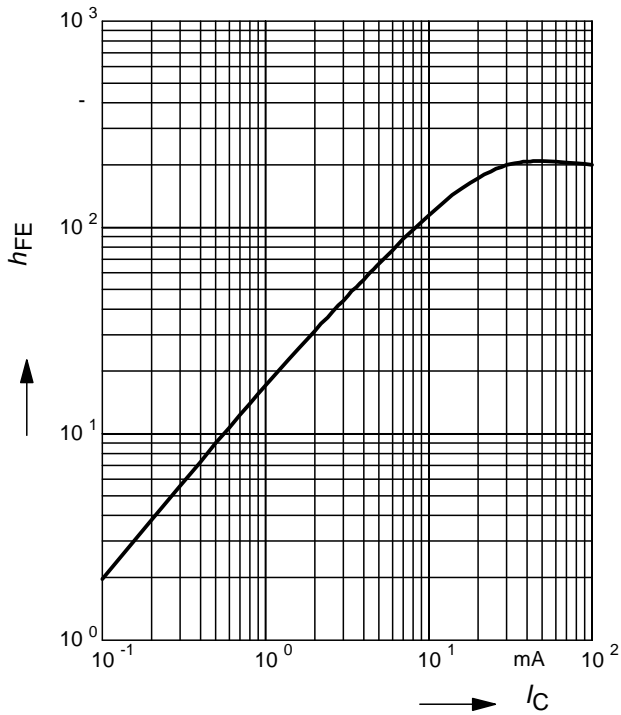
Electrical Characteristics at $T_A = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics					
Collector-emitter breakdown voltage $I_C = 100 \mu\text{A}, I_B = 0$	$V_{(BR)CEO}$	50	-	-	V
Collector-base breakdown voltage $I_C = 10, I_E = 0$	$V_{(BR)CBO}$	50	-	-	
Collector-base cutoff current $V_{CB} = 40 \text{ V}, I_E = 0$	I_{CBO}	-	-	100	nA
Emitter-base cutoff current $V_{EB} = 10 \text{ V}, I_C = 0$	I_{EBO}	-	-	0.75	mA
DC current gain ¹⁾ $I_C = 5 \text{ mA}, V_{CE} = 5 \text{ V}$	h_{FE}	30	-	-	-
Collector-emitter saturation voltage ¹⁾ $I_C = 10 \text{ mA}, I_B = 0.5 \text{ mA}$	V_{CEsat}	-	-	0.3	V
Input off voltage $I_C = 100 \mu\text{A}, V_{CE} = 5 \text{ V}$	$V_{i(off)}$	0.8	-	1.5	
Input on voltage $I_C = 2 \text{ mA}, V_{CE} = 0.3 \text{ V}$	$V_{i(on)}$	1	-	2.5	
Input resistor	R_1	7	10	13	k Ω
Resistor ratio	R_1/R_2	0.9	1	1.1	-
AC Characteristics					
Transition frequency $I_C = 10 \text{ mA}, V_{CE} = 5 \text{ V}, f = 100 \text{ MHz}$	f_T	-	130	-	MHz
Collector-base capacitance $V_{CB} = 10 \text{ V}, f = 1 \text{ MHz}$	C_{cb}	-	3	-	pF

¹⁾Pulse test: $t < 300 \mu\text{s}$; $D < 2\%$

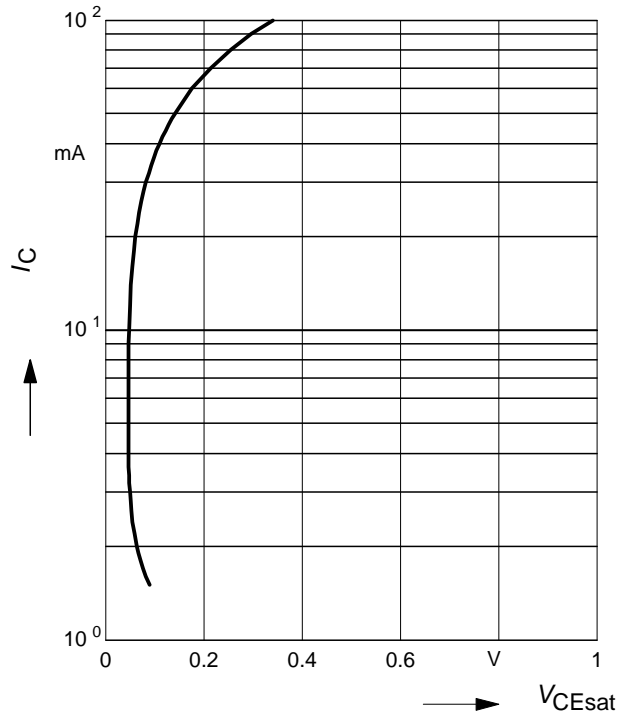
DC current gain $h_{FE} = f(I_C)$

$V_{CE} = 5\text{ V}$ (common emitter configuration)



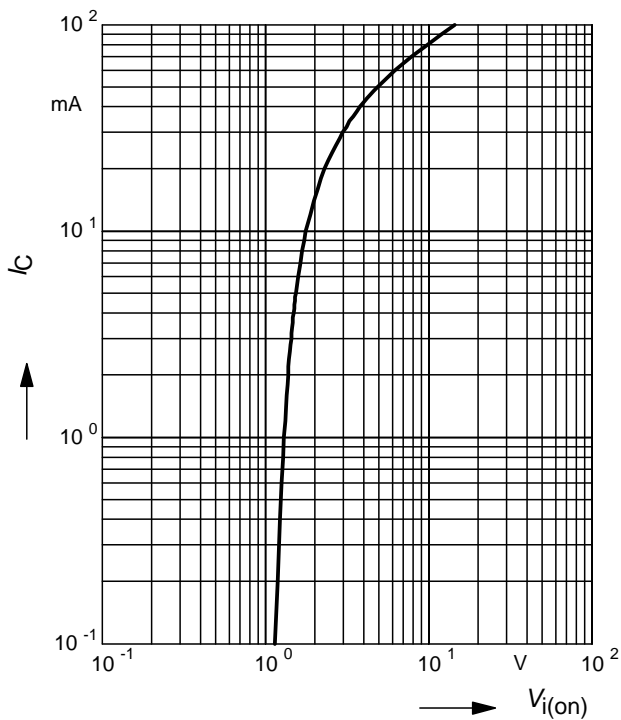
Collector-emitter saturation voltage

$V_{CEsat} = f(I_C), h_{FE} = 20$



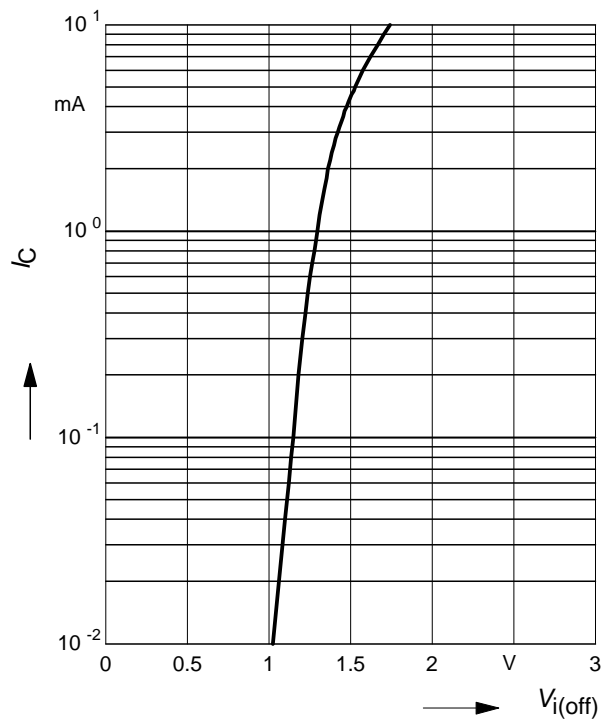
Input on Voltage $V_{i(on)} = f(I_C)$

$V_{CE} = 0.3\text{ V}$ (common emitter configuration)



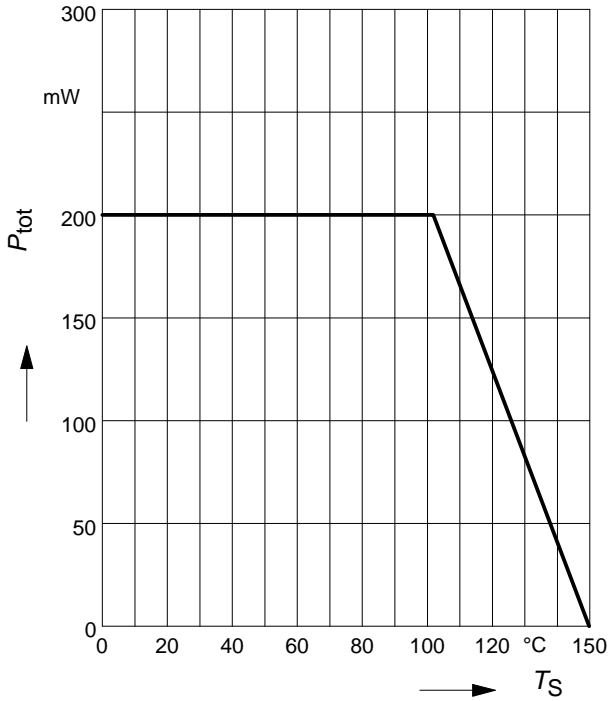
Input off voltage $V_{i(off)} = f(I_C)$

$V_{CE} = 5\text{ V}$ (common emitter configuration)



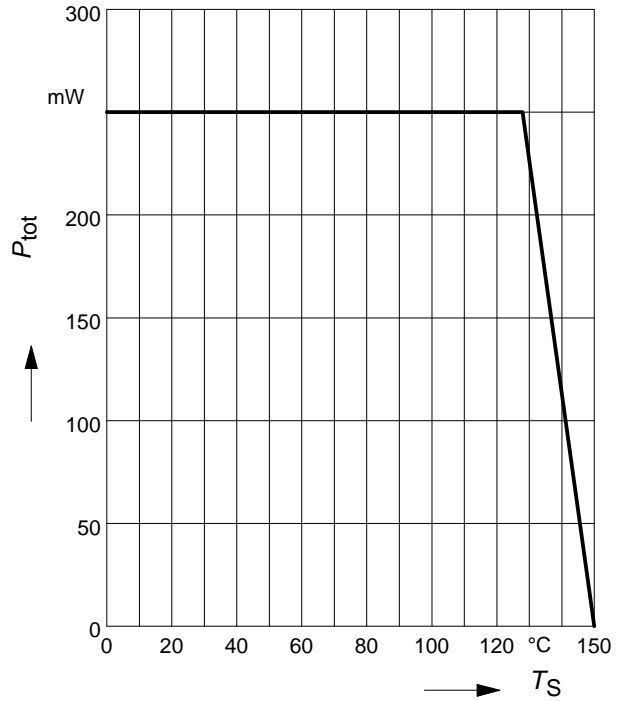
Total power dissipation $P_{tot} = f(T_S)$

BCR133



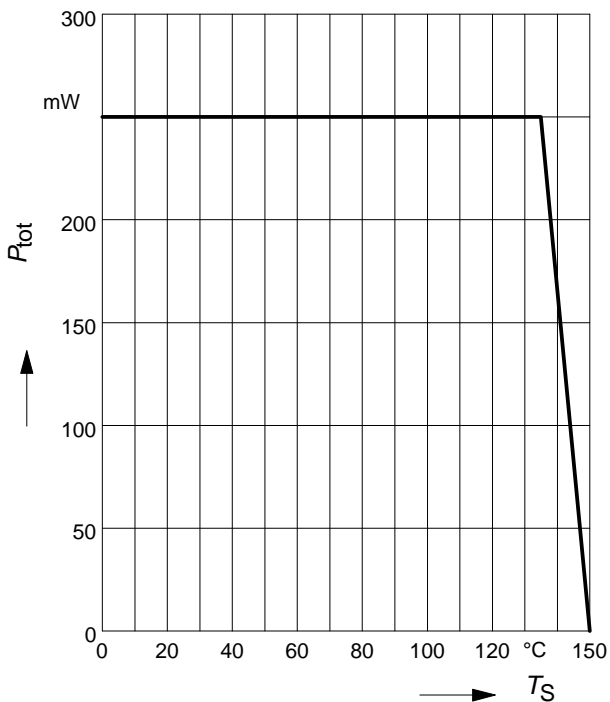
Total power dissipation $P_{tot} = f(T_S)$

BCR133F



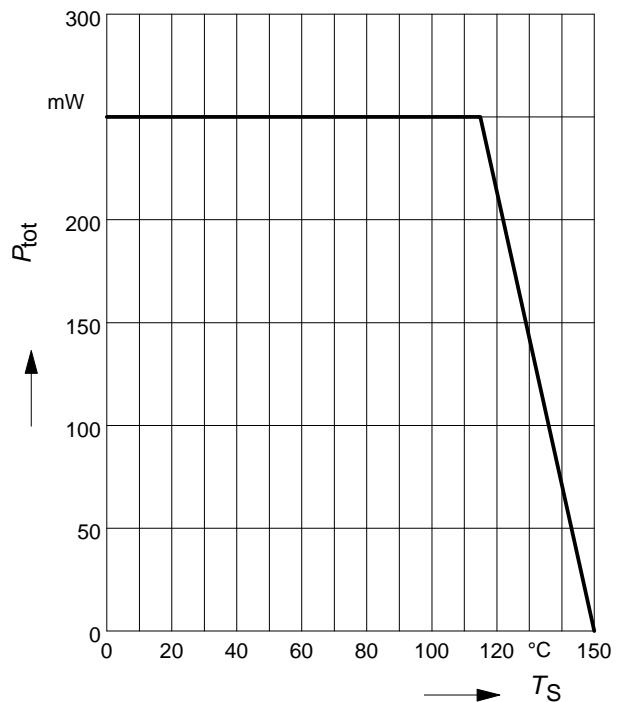
Total power dissipation $P_{tot} = f(T_S)$

BCR133L3



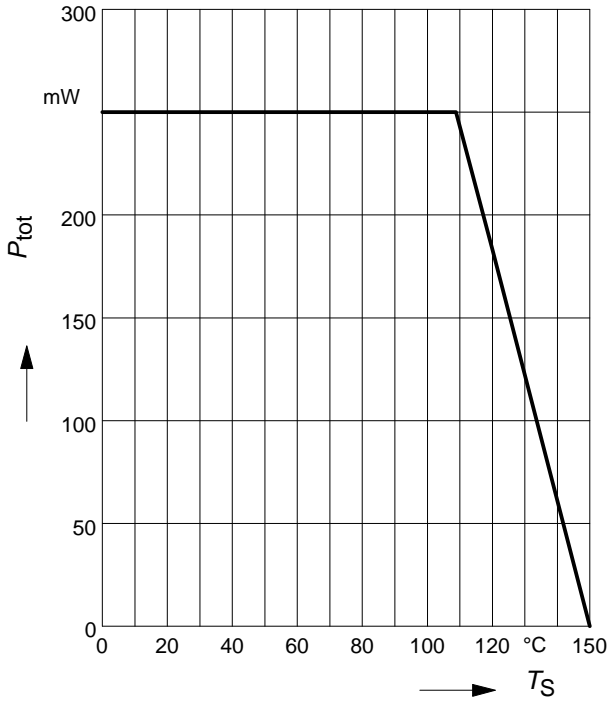
Total power dissipation $P_{tot} = f(T_S)$

BCR133S



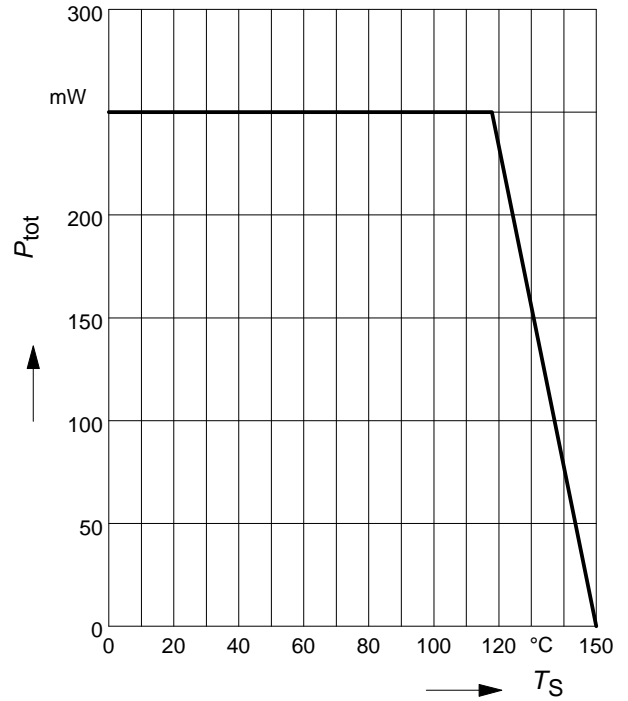
Total power dissipation $P_{tot} = f(T_S)$

BCR133T



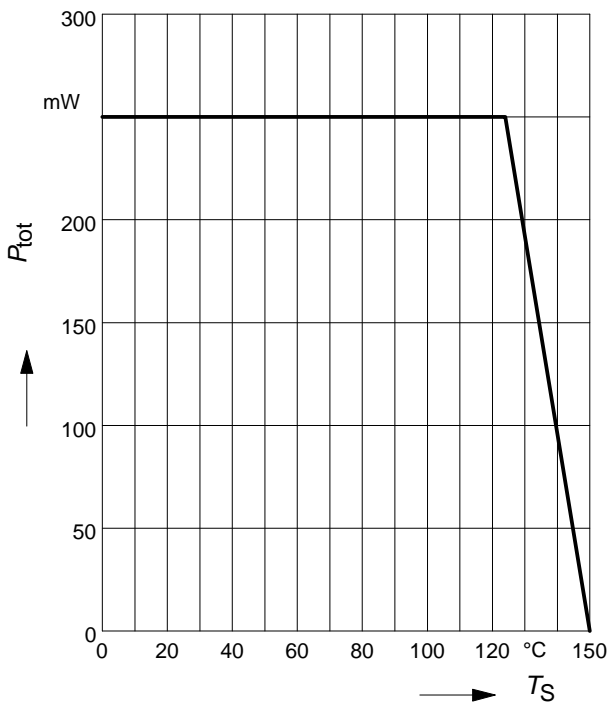
Total power dissipation $P_{tot} = f(T_S)$

BCR133U



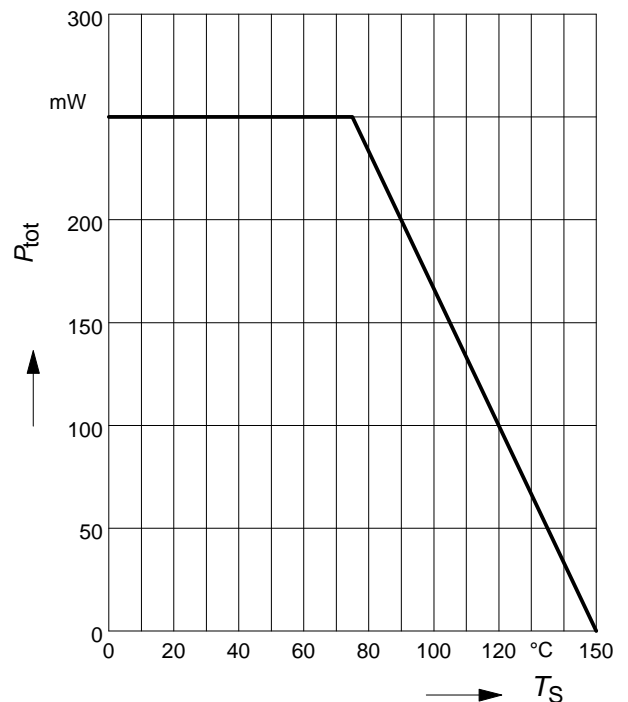
Total power dissipation $P_{tot} = f(T_S)$

BCR133W



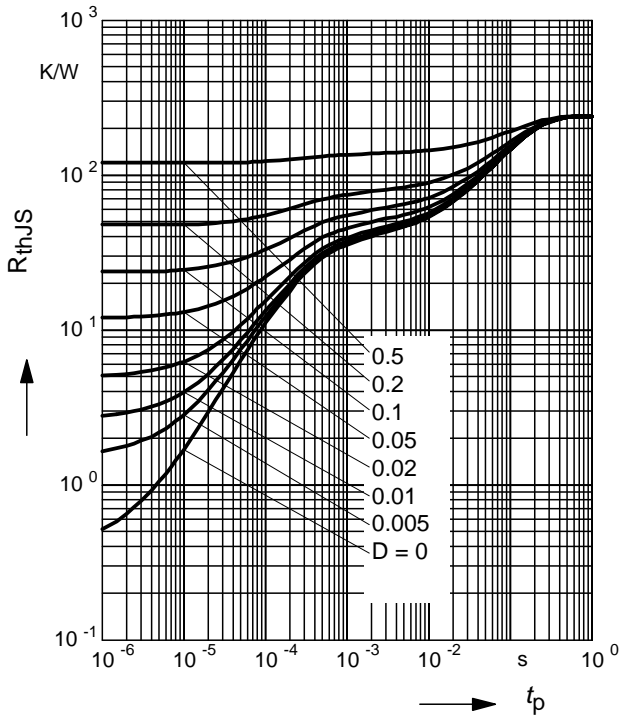
Total power dissipation $P_{tot} = f(T_S)$

SEMH11



Permissible Pulse Load $R_{thJS} = f(t_p)$

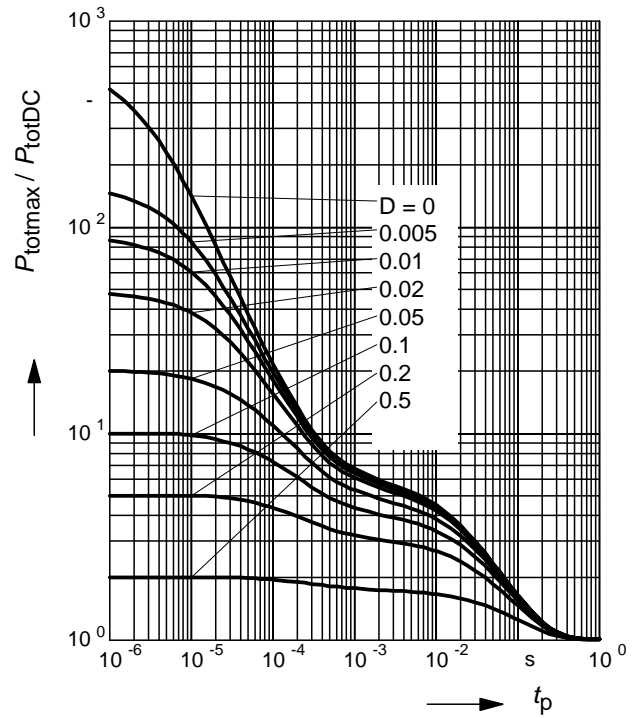
BCR133



Permissible Pulse Load

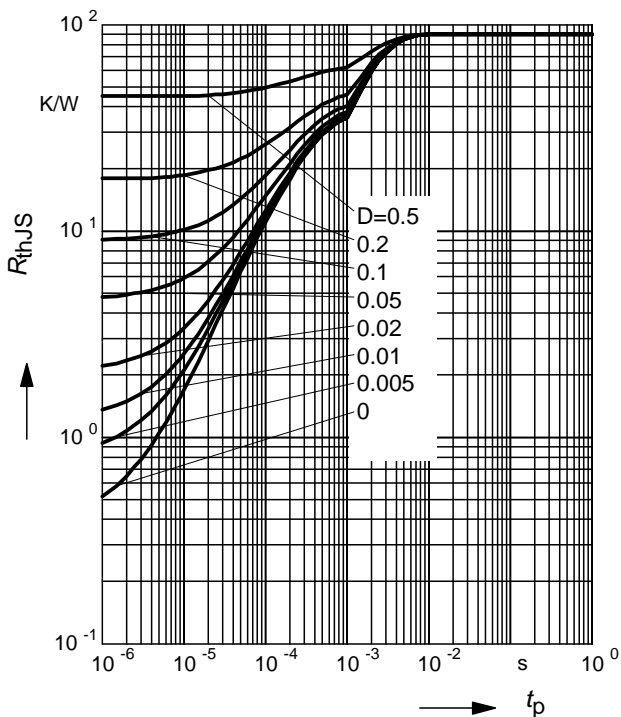
$P_{totmax}/P_{totDC} = f(t_p)$

BCR133



Permissible Puls Load $R_{thJS} = f(t_p)$

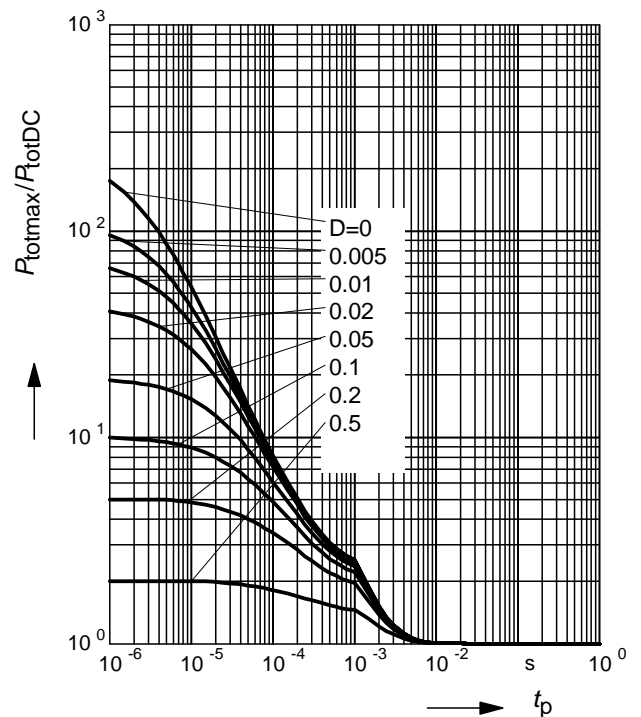
BCR133F



Permissible Pulse Load

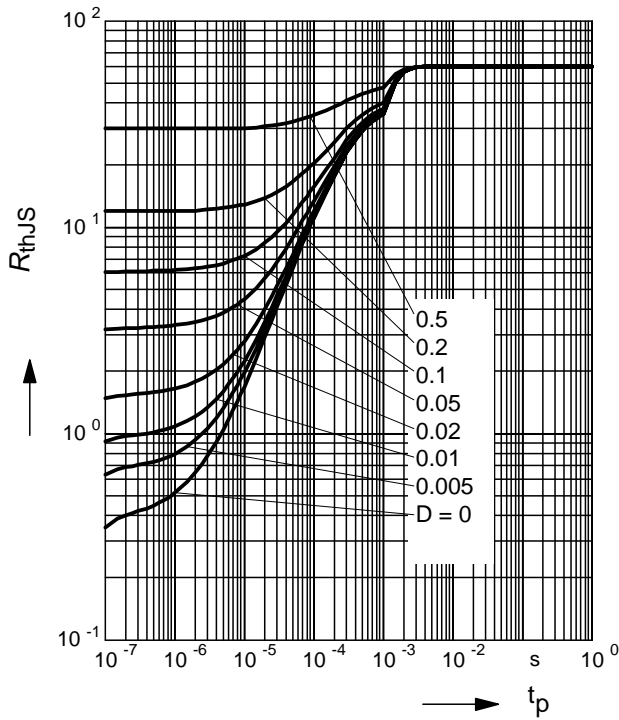
$P_{totmax}/P_{totDC} = f(t_p)$

BCR133F



Permissible Puls Load $R_{thJS} = f(t_p)$

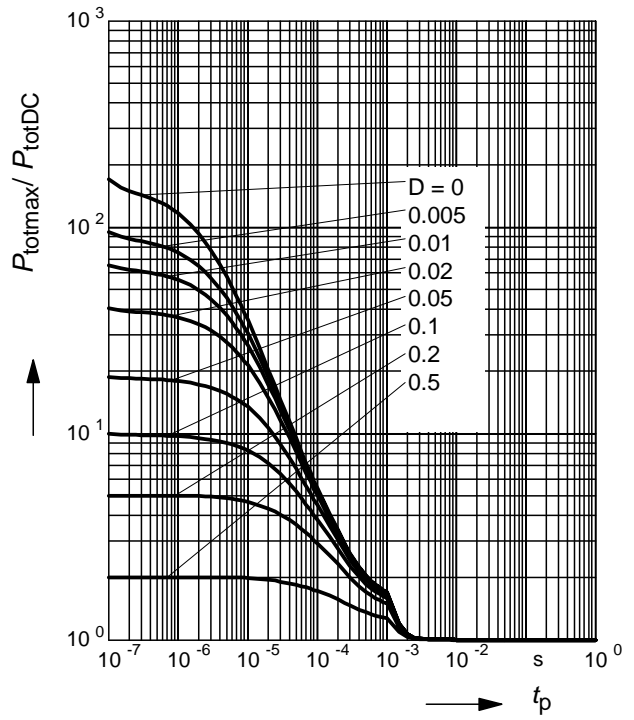
BCR133L3



Permissible Pulse Load

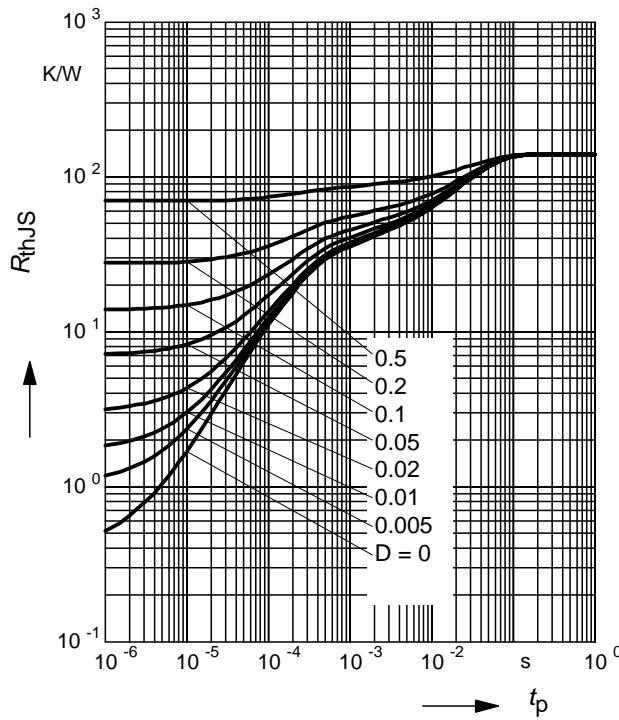
$P_{totmax}/P_{totDC} = f(t_p)$

BCR133L3



Permissible Puls Load $R_{thJS} = f(t_p)$

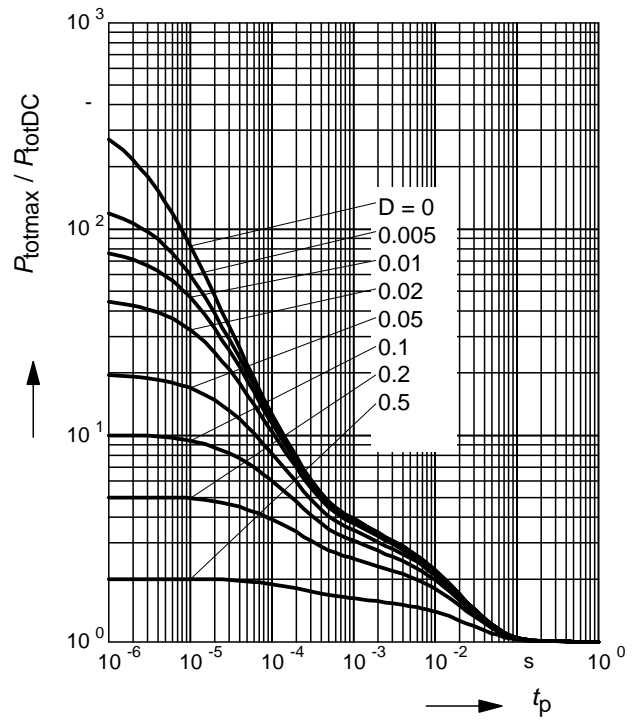
BCR133S



Permissible Pulse Load

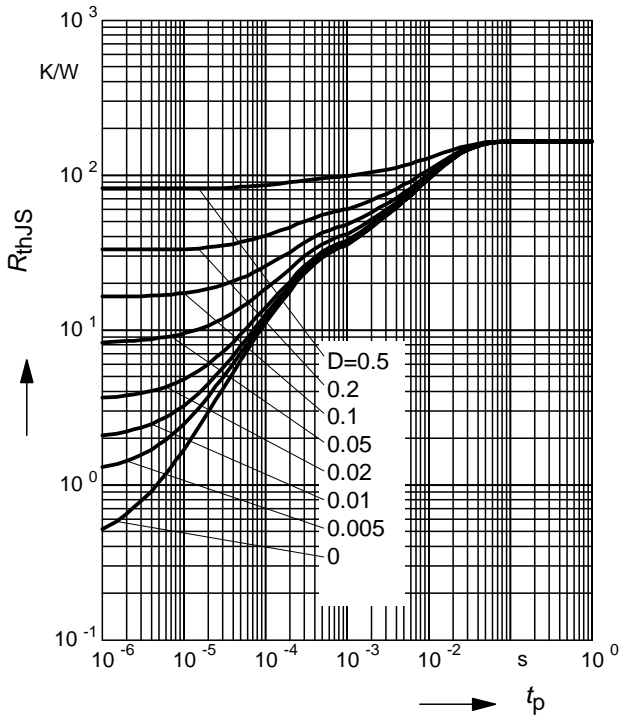
$P_{totmax}/P_{totDC} = f(t_p)$

BCR133S



Permissible Puls Load $R_{thJS} = f(t_p)$

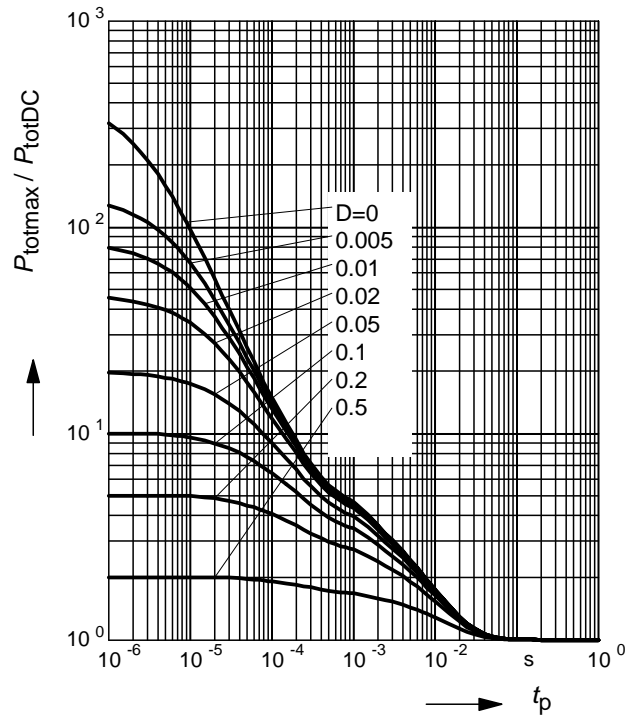
BCR133T



Permissible Pulse Load

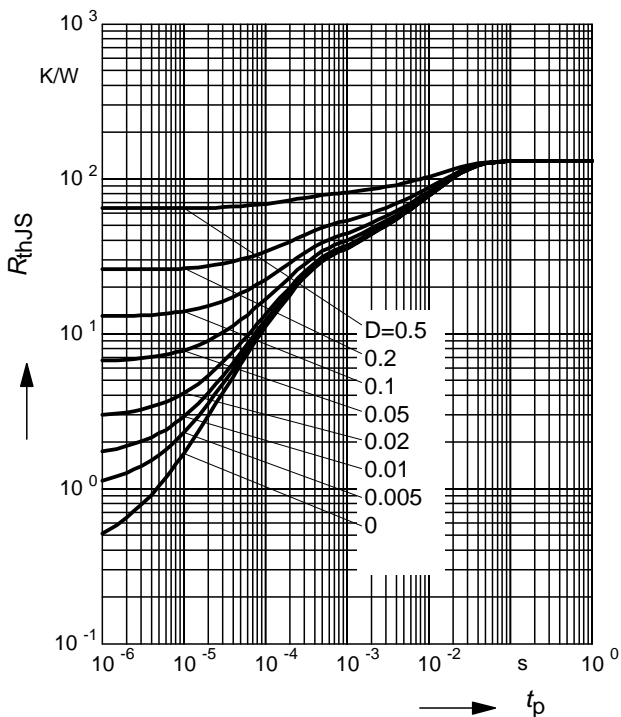
$P_{totmax}/P_{totDC} = f(t_p)$

BCR133T



Permissible Puls Load $R_{thJS} = f(t_p)$

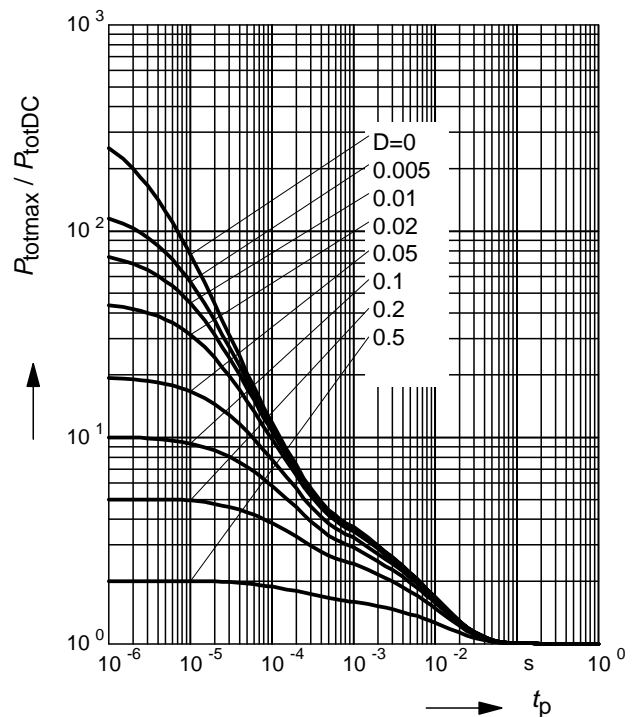
BCR133U



Permissible Pulse Load

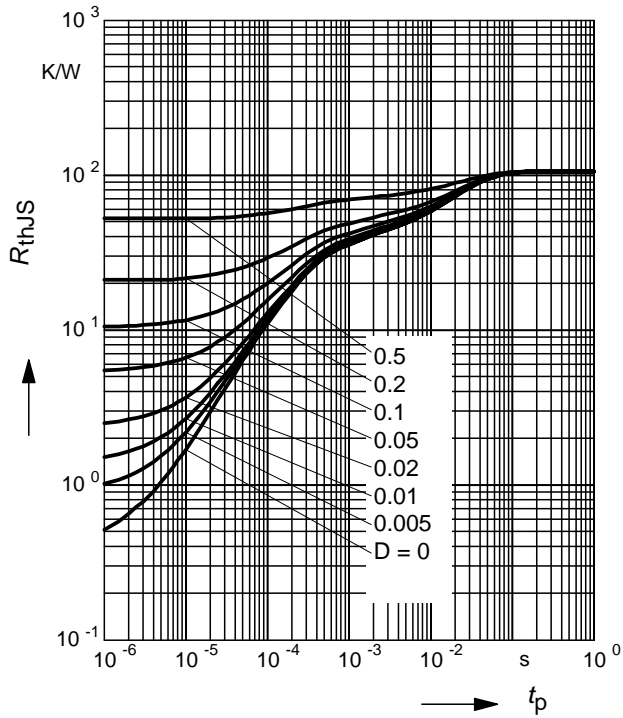
$P_{totmax}/P_{totDC} = f(t_p)$

BCR133U



Permissible Puls Load $R_{thJS} = f(t_p)$

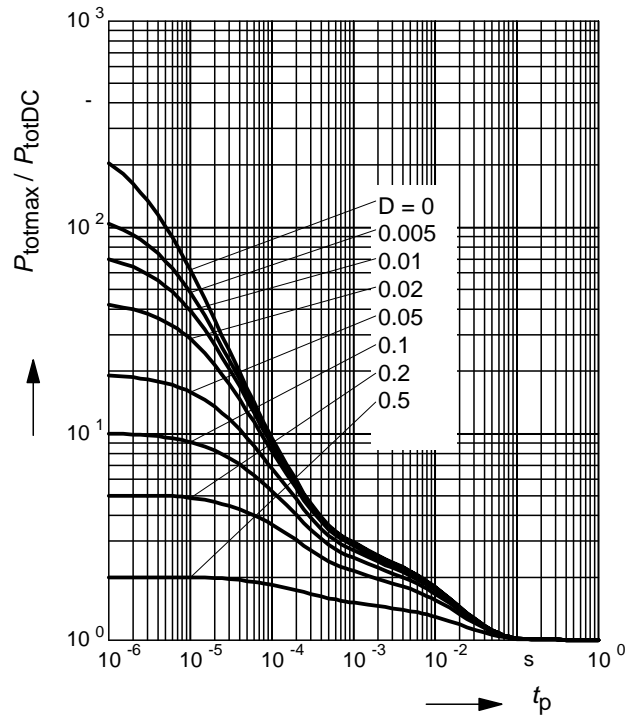
BCR133W



Permissible Pulse Load

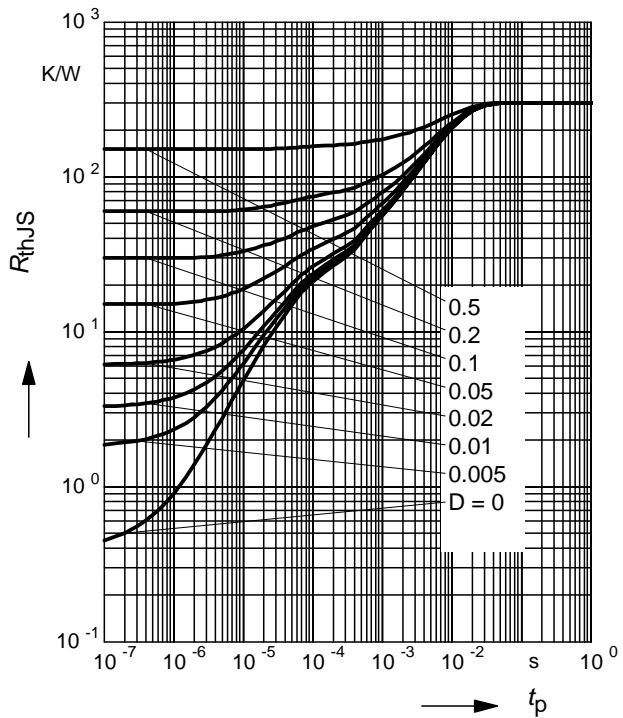
$P_{totmax}/P_{totDC} = f(t_p)$

BCR133W



Permissible Puls Load $R_{thJS} = f(t_p)$

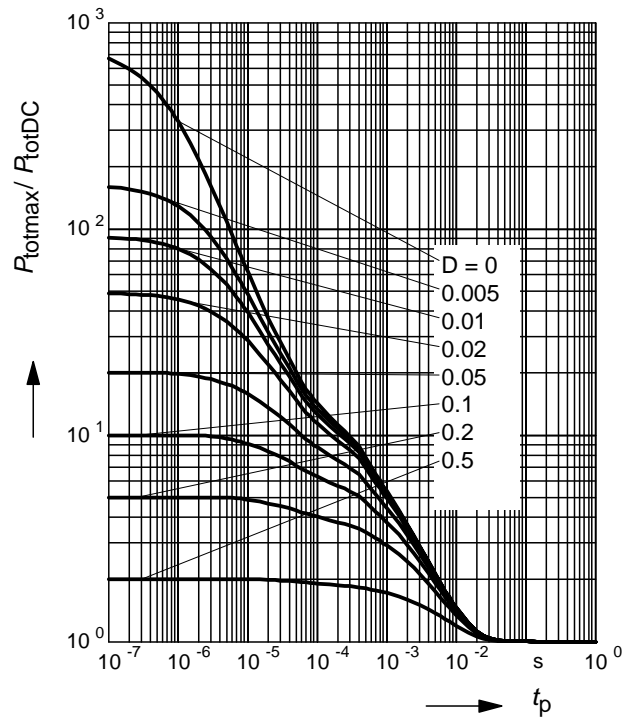
SEM11



Permissible Pulse Load

$P_{totmax}/P_{totDC} = f(t_p)$

SEM11



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